TEXAS INSTRUMENTS
SN54AC00-SP
JAJSN46C – OCTOBER 2008 – REVISED APRIL 2022

SN54AC00-SP 耐放射線特性クワッド 2 入力 NAND ゲート

1 特長

- 5962R87549:
  - 放射線耐性保証 (RHA):TID 最大 100krad (Si)
  - SEL 耐性:86MeV×cm^2/mg
- 5962-87549:
  - 総照射線量耐性:50krad (Si)
- 2V～6V の V_{CC} で動作
- 6V までの入力電圧に対応
- 最大 t_{pd} 7ns (5V 時)

2 アプリケーション

- 衛星観測機器
- 衛星パワー・オン・リセット・ロジック
- 宇宙ハイブリッド向け RHA 品質保証のベア・ダイ (KGD)

ピン機能 (各ゲート)

入力		出力
A	B	Y
H	H	L
L	X	H
X	L	H



論理図 (正論理)

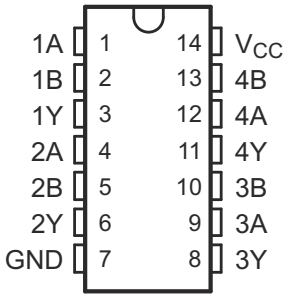
3 概要

SN54AC00 デバイスには、4 つの独立した 2 入力 NAND ゲートが内蔵されています。各ゲートは、ブール関数 $Y = \overline{A \cdot B}$ または $Y = \overline{A} + \overline{B}$ を正論理で実行します。

製品情報(1)

部品番号	パッケージ	本体サイズ (公称)
SN54AC00-SP	CDIP (14)	5.97mm × 9.21mm
	CFP (14)	6.67mm × 19.56mm
	KGD (0)	該当なし

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。



J または W パッケージ
(上面図)

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4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision B (October 2015) to Revision C (April 2022) — **Page**

- 文書全体にわたって表、図、相互参照の採番方法を更新 ... 1
- 「特長」セクションから SEU を削除 ... 1
- SEL 耐性を 86MeV×cm^2/mg に変更 ... 1

Changes from Revision A (December 2013) to Revision B (February 2015) — **Page**

- KGD パッケージ情報を追加 ... 1
- 「デバイスおよびドキュメントのサポート」セクションと「メカニカル、パッケージ、および注文情報」セクションを追加 ... 1
- Added *Bare Die Information*, image, and *Bond Pad Coordinates in Microns* ... 3
- Added parameter information for KGD to *セクション 6.5* and *セクション 6.6* ... 6

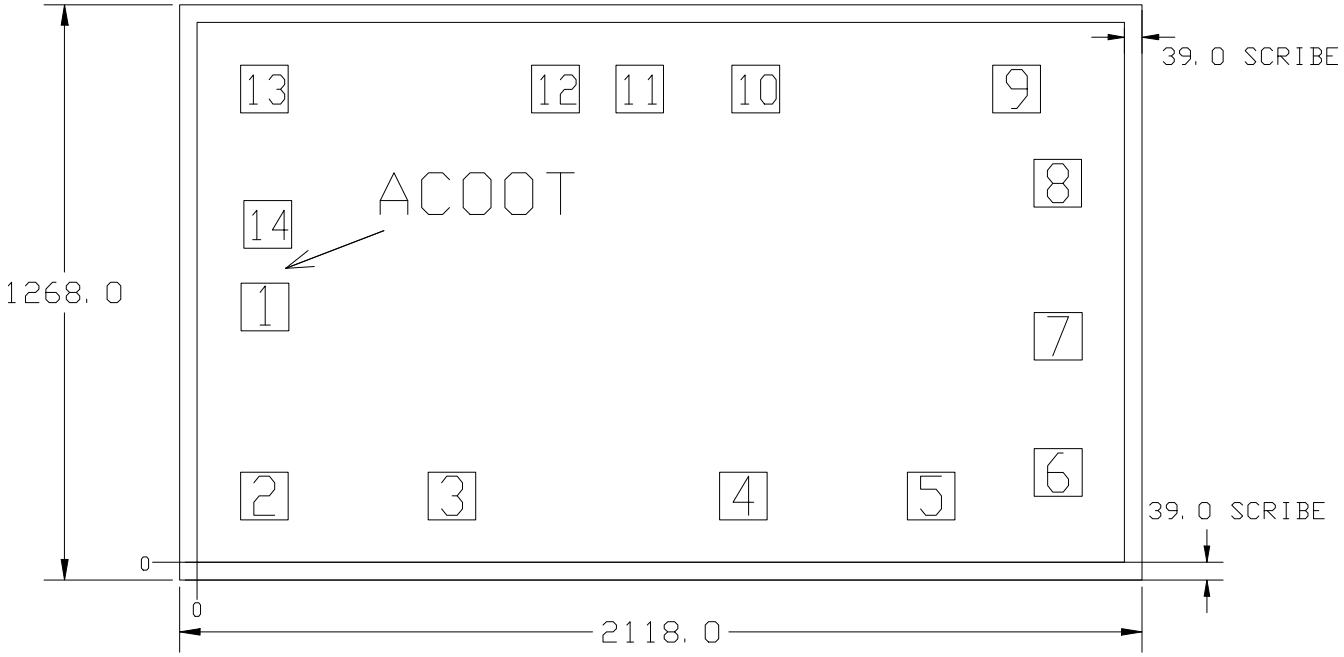
Changes from Revision * (October 2008) to Revision A (December 2013) — **Page**

- 「特長」の箇条書きを変更 ... 1
- 「注文情報」表を削除 ... 1

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5 Bare Die Information

DIE THICKNESS	BACKSIDE FINISH	BACKSIDE POTENTIAL	BOND PAD METALLIZATION COMPOSITION	BOND PAD THICKNESS
15 mils	Silicon with backgrind	Floating	TiW/AlCu2	15800 nm



Bond Pad Coordinates in Microns

DESCRIPTION	PAD NUMBER	X MIN	Y MIN	X MAX	Y MAX
1A	1	96.3	510.5	201.3	615.5
1B	2	95	94	200	199
1Y	3	508	94	613	199
2A	4	1149	94	1254	199
2B	5	1562	94	1667	199
2Y	6	1841.5	145.5	1946.5	250.5
GND	7	1841.5	445.5	1946.5	550.5
3Y	8	1841	783	1946	888
3A	9	1750.5	991	1855.5	1096
3B	10	1176.5	991	1281.5	1096
4Y	11	921	991	1026	1096
4A	12	736	991	841	1096
4B	13	95	991	200	1096
VCC	14	102.5	692	207.5	797

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V_{CC}	Supply voltage		–0.5	7	V
V_I	Input voltage(2)		–0.5	V_{CC} + 0.5	V
V_O	Output voltage(2)		–0.5	V_{CC} + 0.5	V
I_{IK}	Input clamp current	V_I < 0 or V_I > V_{CC}		±20	mA
I_{OK}	Output clamp current	V_O < 0 or V_O > V_{CC}		±20	mA
I_O	Continuous output current	V_O = 0 to V_{CC}		±50	mA
	Continuous current through V_{CC} or GND			±200	mA
T_J	Junction temperature			150	°C
T_{stg}	Storage temperature		–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

6.2 Recommended Operating Conditions

			MIN	MAX	UNIT
V_{CC}	Supply voltage		2	6	V
V_{IH}	High-level input voltage	V_{CC} = 3 V	2.1		V
		V_{CC} = 4.5 V	3.15		
		V_{CC} = 5.5 V	3.85		
V_{IL}	Low-level input voltage	V_{CC} = 3 V		0.9	V
		V_{CC} = 4.5 V		1.35	
		V_{CC} = 5.5 V		1.65	
V_I	Input voltage		0	V_{CC}	V
V_O	Output voltage		0	V_{CC}	V
I_{OH}	High-level output current	V_{CC} = 3 V		12	mA
		V_{CC} = 4.5 V		24	
		V_{CC} = 5.5 V		24	
I_{OL}	Low-level output current	V_{CC} = 3 V		12	mA
		V_{CC} = 4.5 V		24	
		V_{CC} = 5.5 V		24	
Δt/Δv	Input transition rise or fall rate			8	ns/V
T_A	Operating free-air temperature		–55	125	°C

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6.3 Thermal Information

THERMAL METRIC[1] [2]		SN54AC00-SP		UNIT
		J	W	
		14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	83.1	125.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	26.6	30.85	
$R_{\theta JB}$	Junction-to-board thermal resistance	47.9	43.4	
ψ_{JT}	Junction-to-top characterization parameter	N/A	N/A	
ψ_{JB}	Junction-to-board characterization parameter	N/A	N/A	
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.
(2) The package thermal impedance is calculated in accordance with JESD 51-7 and Mil Std 883 method 1012.1 (see www.JEDEC.org).

6.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V_{CC}	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
V_{OH}	I_{OH} = –50 µA	3 V	2.9			2.9		V
		4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
	I_{OH} = –12 mA	3 V	2.56			2.4		
	I_{OH} = –24 mA	4.5 V	3.86			3.7		
		5.5 V	4.86			4.7		
	I_{OH} = –50 mA[1]	5.5 V				3.85		
V_{OL}	I_{OL} = 50 µA	3 V			0.1		0.1	V
		4.5 V			0.1		0.1	
		5.5 V			0.1		0.1	
	I_{OL} = 12 mA	3 V			0.36		0.5	
	I_{OL} = 24 mA	4.5 V			0.36		0.5	
		5.5 V			0.36		0.5	
	I_{OL} = 50 mA[1]	5.5 V					1.65	
I_I	V_I = V_{CC} or GND	5.5 V			±0.1		±1	µA
I_{CC}	V_I = V_{CC} or GND, I_O = 0	5.5 V			4		40	µA
C_i	V_I = V_{CC} or GND	5 V		2.6				pF

(1) Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

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6.5 Switching Characteristics, V_{CC} = 3.3 V

over recommended operating free-air temperature range, V_{CC} = 3.3 V ±0.3 V (unless otherwise noted) (see 図 7-1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
t_{PLH}	A or B	Y	2	7	9.5	1	11	ns
t_{PHL}			1.5	5.5	8	1	9	
t_{PLH} (KGD only)(1)	A or B	Y	1	7	9.5	1	11	ns
t_{PHL} (KGD only)(1)			1	5.5	9.5	1	11	

(1) Specification limits for KGD are based on SMD 5962-8754903

6.6 Switching Characteristics, V_{CC} = 5 V

over recommended operating free-air temperature range, V_{CC} = 5 V ±0.5 V (unless otherwise noted) (see 図 7-1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
t_{PLH}	A or B	Y	1.5	6	8	1	8.5	ns
t_{PHL}			1.5	4.5	6.5	1	7	
t_{PLH} (KGD only)(1)	A or B	Y	1.5	6	8	1	8.5	ns
t_{PHL} (KGD only)(1)			1.5	4.5	8	1	8.5	

(1) Specification limits for KGD are based on SMD 5962-8754903

6.7 Operating Characteristics

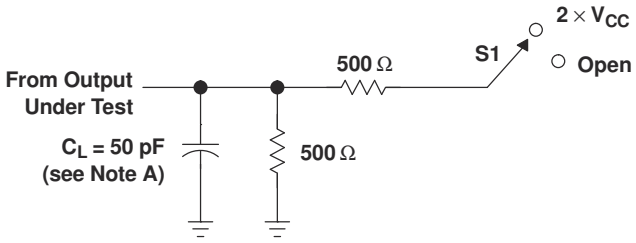
V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS	TYP	UNIT
C_{pd}	Power dissipation capacitance	C_L = 50 pF, f = 1 MHz	40	pF

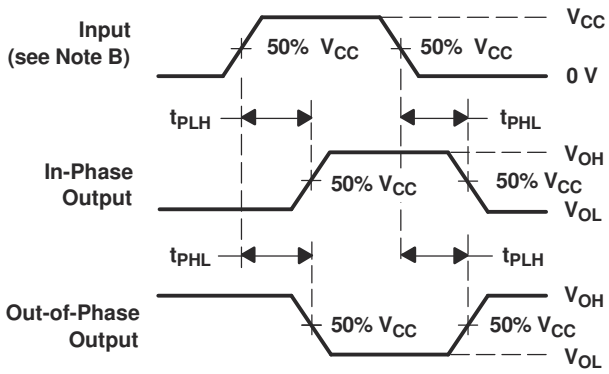
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7 Parameter Measurement Information

TEST	S1
t_{PLH}/t_{PHL}	Open



LOAD CIRCUIT



VOLTAGE WAVEFORMS

NOTES: A. C_L includes probe and jig capacitance.
B. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, Z_O = 50 Ω, t_r ≤ 2.5 ns, t_f ≤ 2.5 ns.
C. The outputs are measured one at a time with one input transition per measurement.

図 7-1. Load Circuit and Voltage Waveforms

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8 Device and Documentation Support

8.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.2 サポート・リソース

TI E2E™ サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計で必要な支援を迅速に得ることができます。

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8.3 Trademarks

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8.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.5 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
5962-8754903VCA	Active	Production	CDIP (J) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8754903VC A SNV54AC00J
5962-8754903VCA.A	Active	Production	CDIP (J) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8754903VC A SNV54AC00J
5962-8754903VDA	Active	Production	CFP (W) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8754903VD A SNV54AC00W
5962-8754903VDA.A	Active	Production	CFP (W) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962-8754903VD A SNV54AC00W
5962R8754903V9A	Active	Production	XCEPT (KGD) | 0	95 | JEDEC TRAY (5+1)	Yes	Call TI	N/A for Pkg Type	-55 to 125	
5962R8754903V9A.A	Active	Production	XCEPT (KGD) | 0	95 | JEDEC TRAY (5+1)	Yes	Call TI	N/A for Pkg Type	-55 to 125	
5962R8754903VCA	Active	Production	CDIP (J) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962R8754903VC A SNVR54AC00J
5962R8754903VCA.A	Active	Production	CDIP (J) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962R8754903VC A SNVR54AC00J
5962R8754903VDA	Active	Production	CFP (W) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962R8754903VD A SNVR54AC00W
5962R8754903VDA.A	Active	Production	CFP (W) | 14	25 | TUBE	No	SNPB	N/A for Pkg Type	-55 to 125	5962R8754903VD A SNVR54AC00W

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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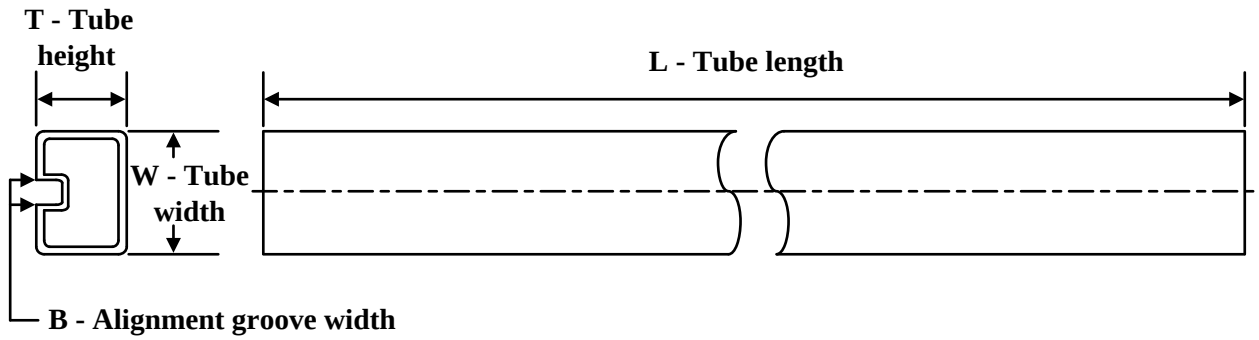
OTHER QUALIFIED VERSIONS OF SN54AC00-SP :

- Catalog : SN54AC00

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

TUBE



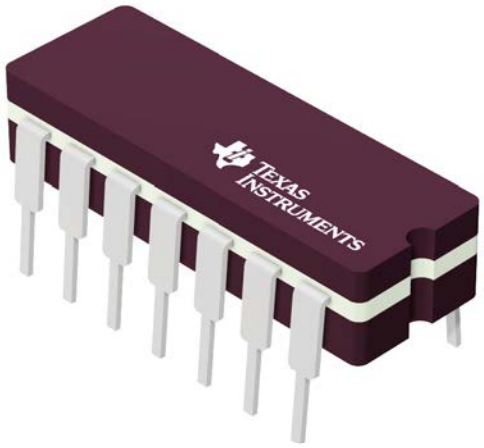
*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-8754903VDA	W	CFP	14	25	506.98	26.16	6220	NA
5962-8754903VDA.A	W	CFP	14	25	506.98	26.16	6220	NA
5962R8754903VCA	J	CDIP	14	25	506.98	15.24	13440	NA
5962R8754903VCA.A	J	CDIP	14	25	506.98	15.24	13440	NA
5962R8754903VDA	W	CFP	14	25	506.98	26.16	6220	NA
5962R8754903VDA.A	W	CFP	14	25	506.98	26.16	6220	NA

GENERIC PACKAGE VIEW

J 14 CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4040083-5/G

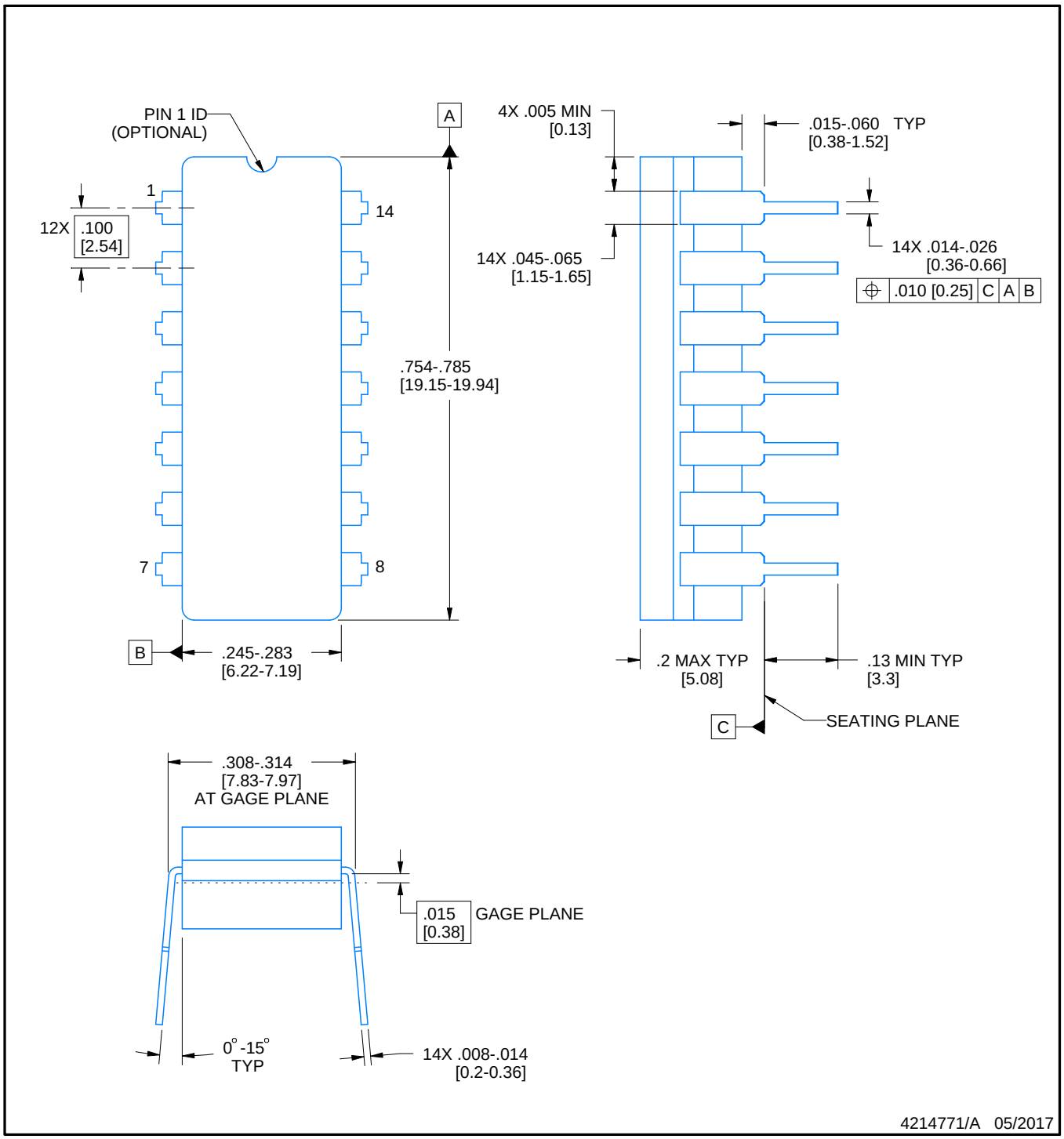


PACKAGE OUTLINE

J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



NOTES:

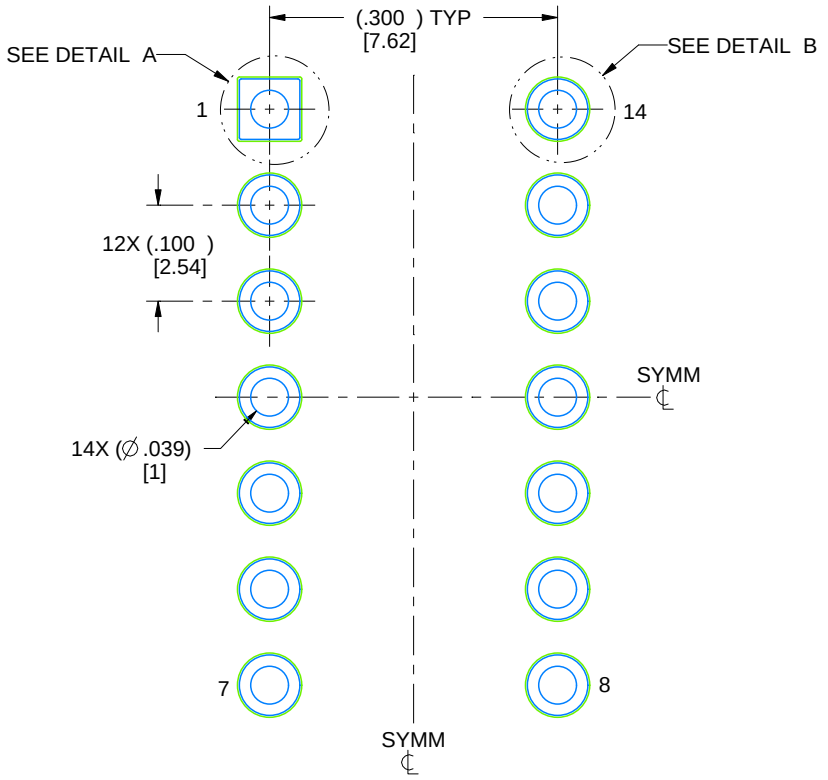
1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermitically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

EXAMPLE BOARD LAYOUT

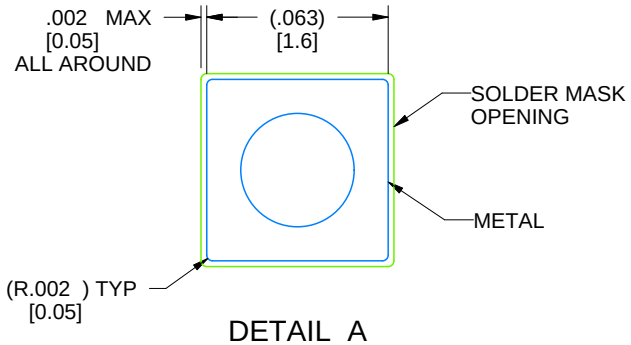
J0014A

CDIP - 5.08 mm max height

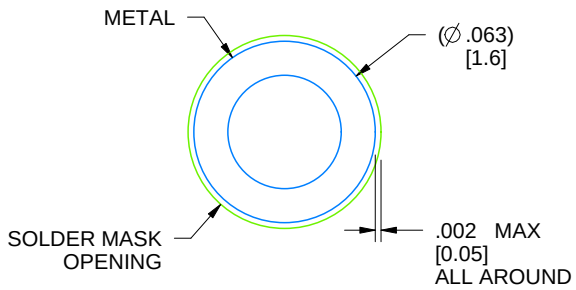
CERAMIC DUAL IN LINE PACKAGE



LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE: 5X



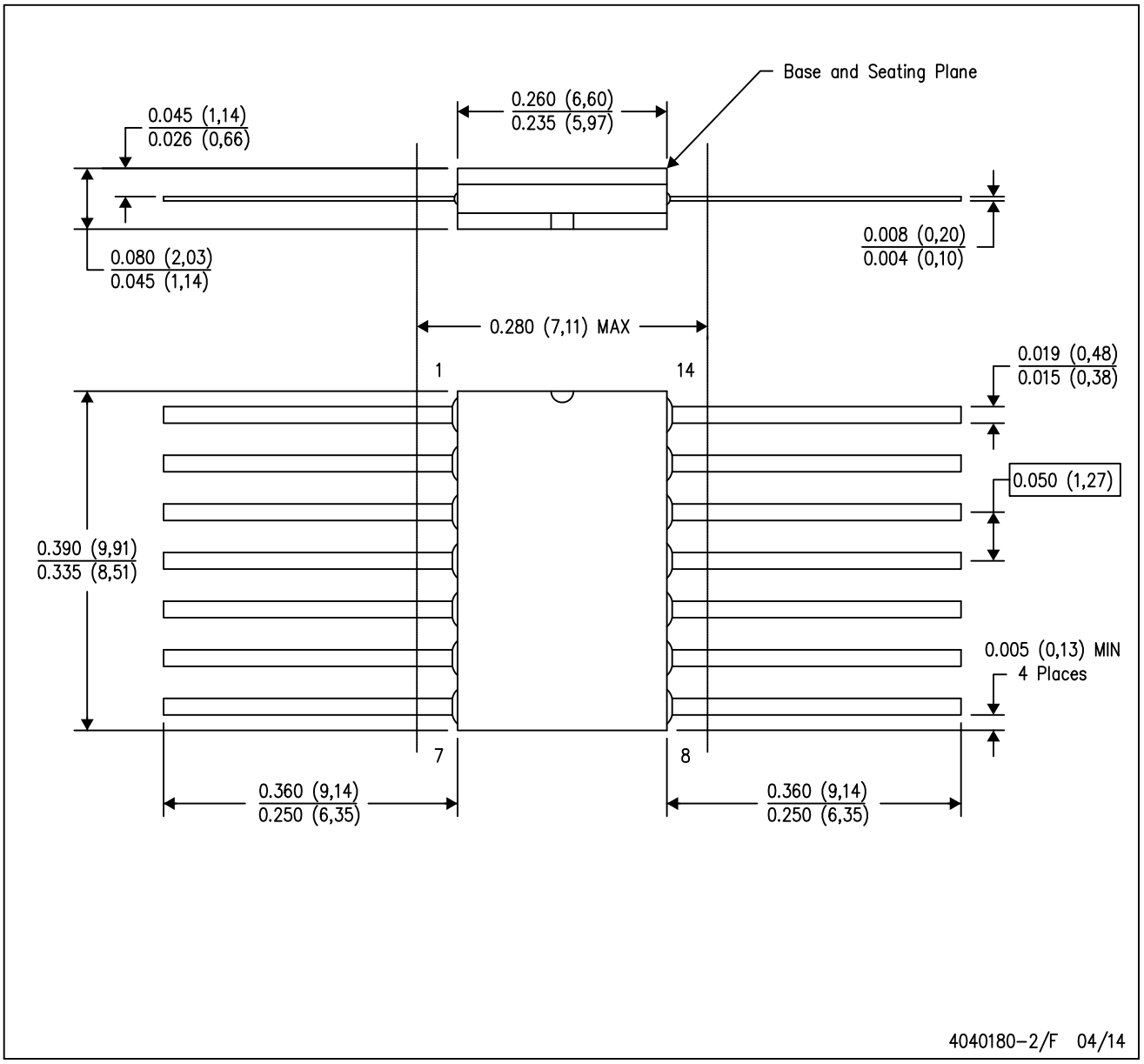
DETAIL A
SCALE: 15X



DETAIL B
13X, SCALE: 15X

4214771/A 05/2017

W (R–GDFP–F14) CERAMIC DUAL FLATPACK



NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only.
E. Falls within MIL STD 1835 GDFP1–F14

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